

TOSHIBA TRANSISTOR SILICON PNP EPITAXIAL TYPE (PCT PROCESS)

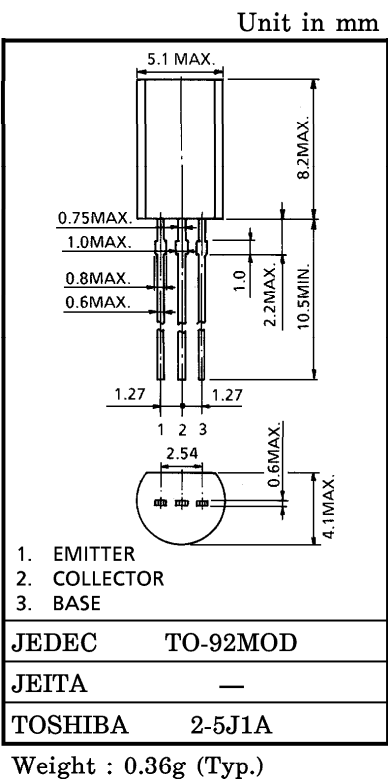
2SA1315

POWER AMPLIFIER APPLICATIONS.
POWER SWITCHING APPLICATIONS.

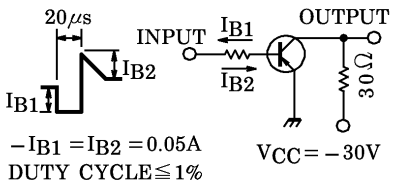
- Low Collector Saturation Voltage
: $V_{CE(sat)} = -0.5V$ (Max.) ($I_C = -1A$)
- High Speed Switching Time : $t_{stg} = 1.0\mu s$ (Typ.)
- Complementary to 2SC3328

MAXIMUM RATINGS ($T_a = 25^\circ C$)

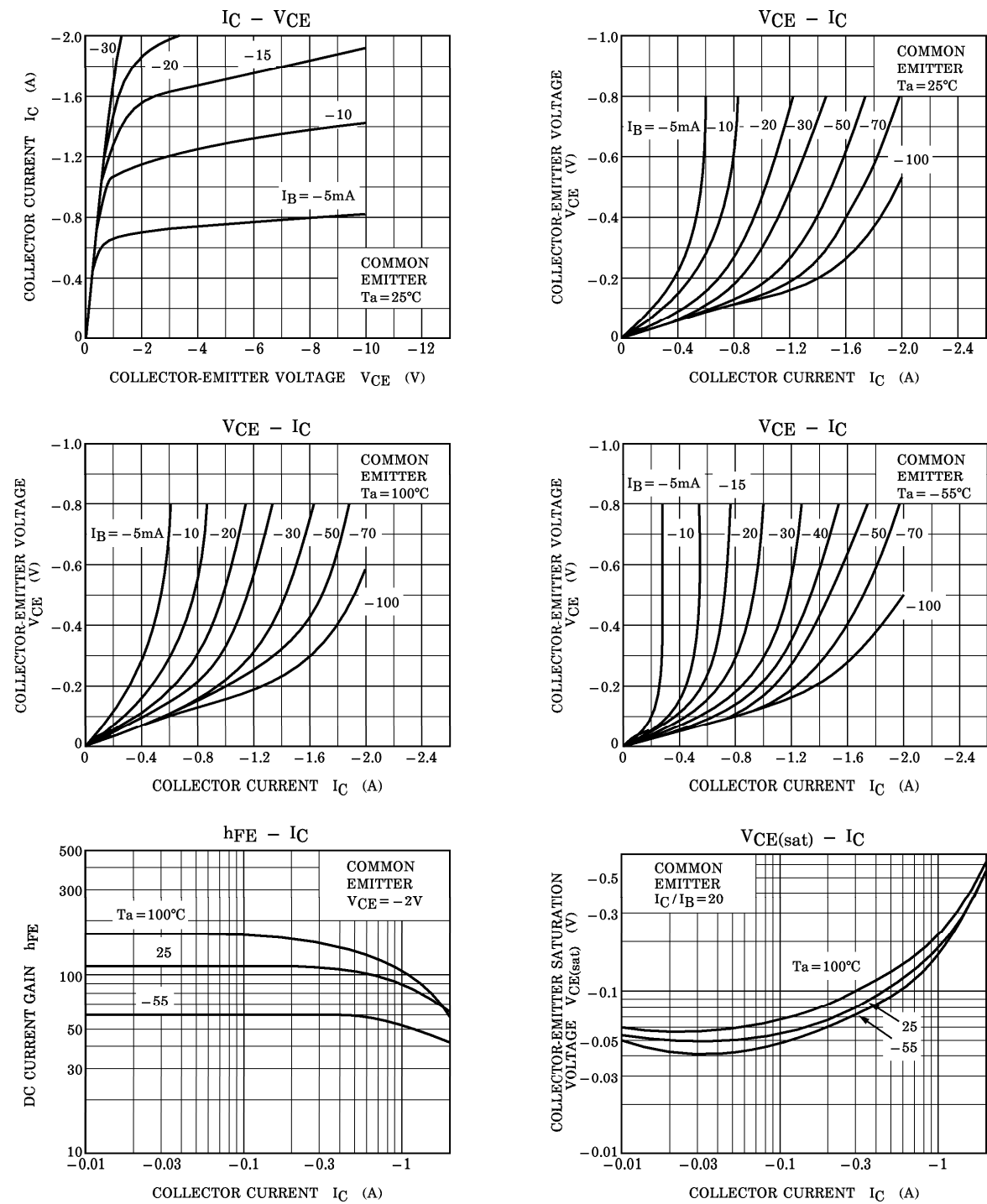
CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	V_{CBO}	-80	V
Collector-Emitter Voltage	V_{CEO}	-80	V
Emitter-Base Voltage	V_{EBO}	-5	V
Collector Current	I_C	-2	A
Base Current	I_B	1	A
Collector Power Dissipation	P_C	900	mW
Junction Temperature	T_j	150	$^\circ C$
Storage Temperature Range	T_{stg}	-55~150	$^\circ C$

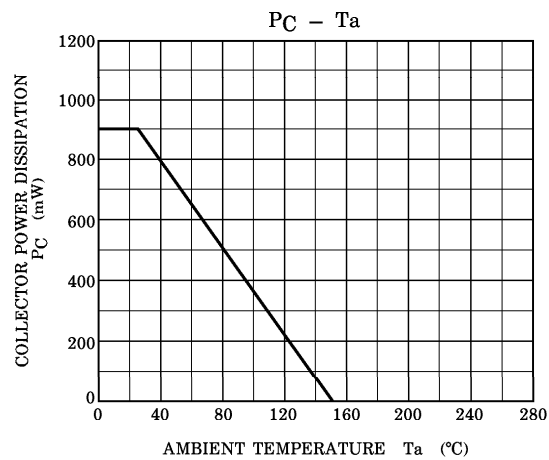
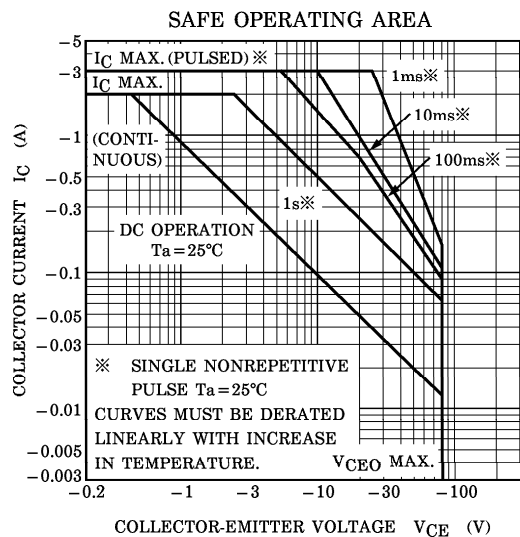
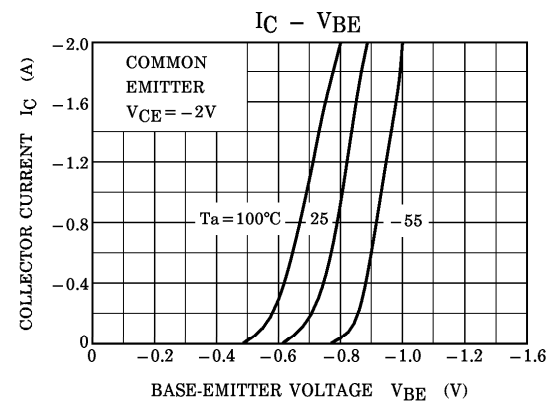
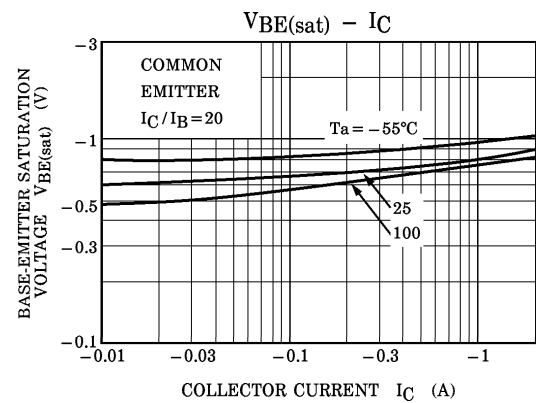


ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		I_{CBO}	$V_{CB} = -80V, I_E = 0$	—	—	-1.0	μA
Emitter Cut-off Current		I_{EBO}	$V_{EB} = -5V, I_C = 0$	—	—	-1.0	μA
Collector-Emitter Breakdown Voltage		$V_{(BR) CEO}$	$I_C = -10mA, I_B = 0$	-80	—	—	V
DC Current Gain	$h_{FE} (1)$ (Note)		$V_{CE} = -2V, I_C = -0.5A$	70	—	240	
	$h_{FE} (2)$		$V_{CE} = -2V, I_C = -1.5A$	40	—	—	
Collector-Emitter Saturation Voltage		$V_{CE (sat)}$	$I_C = -1A, I_B = -0.05A$	—	-0.2	-0.5	V
Base-Emitter Saturation Voltage		$V_{BE (sat)}$	$I_C = -1A, I_B = -0.05A$	—	-0.9	-1.2	V
Transition Frequency		f_T	$V_{CE} = -2V, I_C = -0.5A$	—	80	—	MHz
Collector Output Capacitance		C_{ob}	$V_{CB} = -10V, I_E = 0, f = 1MHz$	—	45	—	pF
Switching Time	Turn-on Time	t_{on}	 <p> $20\mu s$ I_{B1} I_{B2} $-I_{B1} = I_{B2} = 0.05A$ $DUTY\ CYCLE \leq 1\%$ $V_{CC} = -30V$ </p>	—	0.2	—	μs
	Storage Time	t_{stg}		—	1.0	—	
	Fall Time	t_f		—	0.2	—	

(Note) : $h_{FE} (1)$ Classification O : 70~140, Y : 120~240





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